

SAR EVALUATION REPORT

FCC 47 CFR § 2.1093 IEEE Std 1528-2013

For SMARTPHONE

FCC ID: BCG-E8146A, BCG-E8147A, BCG-E8148A Model Name: A2885, A2886, A2887, A2888

> Report Number: 14282070-S1V2 Issue Date: 9/1/2022

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Revision History

Rev.	Date	Revisions	Revised By
V1	8/1/2022	Initial Issue	
V2	9/1/2022	Updated section 8.1, 8.2 and 8.3 table of contents	Devin Chang

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1. Attestation of Test Results

Applicant Name	APPLE, INC.					
FCC ID	BCG-E8146A	BCG-E8146A, BCG-E8147A, BCG-E8148A				
Model Name	A2885, A2886	6, A2887, A288	8			
Applicable Standards	FCC 47 CFR	FCC 47 CFR § 2.1093, Published RF exposure KDB procedures, IEEE Std 1528-2013				
			SAR Lim	its (W/Kg)		
Exposure Category	Peak spatial-average(1g of tissue)			Extremities (hands, wrists, ankles, etc.) (10g of tissue)		
General population / Uncontrolled exposure	1.6 4					
RF Exposure Conditions	Equipment Class - Highest Reported SAR (W/kg)					
	TNE	PCE	CBE	DTS	NII	DSS
Worst Case from BCG-E8141A	1.042 0.948 0.937 1.090 1.148 0.911					
Variant Models		Wo	orst-Case SAR	for Variant Mod	lels	
BCG-E8146A (A2885)	1.026	0.774	0.867	0.982	0.990	0.717
BCG-E8147A (A2886)	1.012 0.762 0.699 0.944 1.098 0.838					0.838
BCG-E8148A (A2887, A2888)	N/A 0.849 0.861 1.138 1.025 0.735					
Date Tested	7/17/2022 to 7/29/2022					
Test Results	Pass					
This application for partification is law arging the data rayse presedure from TCD workshop April 2024, DE Evenesure						

This application for certification is leveraging the data reuse procedure from TCB workshop April 2021; RF Exposure Procedures (Remarks on Test Reductions via Data Referencing for Closely Related Products) based on reference FCC ID: **BCG-E8139A** (UL report# 14040863-S1V5) to cover variant FCC ID: **BCG-E8146A**, **BCG-E8147A**, **BCG-E8148A**. The major difference between the parent/reference model and the variant model is the depopulation in the variant model of the mmWave transmitter. All other circuitry and features are identical. The data reuse test plan was approved via manufacturer KDB inquiry.

UL Verification Services Inc. tested the above equipment in accordance with the requirements set forth in the above standards. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

This report contains data provided by the customer which can impact the validity of results. UL Verification Services Inc. is only responsible for the validity of results after the integration of the data provided by the customer.

The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. All samples tested were in good operating condition throughout the entire test program. Measurement Uncertainties are published for informational purposes only and were not taken into account unless noted otherwise.

This document may not be altered or revised in any way unless done so by UL Verification Services Inc. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Verification Services Inc. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by A2LA, NIST, any agency of the Federal Government, or any agency of the U.S. government.

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UL Verification Services Inc.	UL Verification Services Inc.		

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2. Test Specification, Methods and Procedures

The tests documented in this report were performed in accordance with FCC 47 CFR § 2.1093, IEEE STD 1528-2013, the following FCC Published RF exposure <u>KDB</u> procedures:

- o 248227 D01 802.11 Wi-Fi SAR v02r02
- o 447498 D01 General RF Exposure Guidance v06
- 447498 D03 Supplement C Cross-Reference v01
- o 648474 D04 Handset SAR v01r03
- o 865664 D01 SAR measurement 100 MHz to 6 GHz v01r04
- 865664 D02 RF Exposure Reporting v01r02
- o 941225 D01 3G SAR Procedures v03r01
- $\circ \quad 941225 \text{ D05 SAR for LTE Devices v02r05}$
- 941225 D05A LTE Rel.10 KDB Inquiry Sheet v01r02
- 941225 D06 Hotspot Mode v02r01

In addition to the above, the following information was used:

- o <u>TCB workshop</u> October 2014; RF Exposure Procedures (Other LTE Considerations)
- o <u>TCB workshop</u> April 2015; RF Exposure Procedures (Overlapping LTE Bands)
- o <u>TCB workshop</u> October 2015; RF Exposure Procedures (KDB 941225 D05A)
- <u>TCB workshop</u> April 2016; RF Exposure Procedures (LTE Carrier Aggregation for DL)
- o TCB workshop October 2016; RF Exposure Procedures (LTE Carrier Aggregation for UL)
- o <u>TCB workshop</u> October 2016; RF Exposure Procedures (Bluetooth Duty Factor)
- o <u>TCB workshop</u> October 2016; RF Exposure Procedures (DUT Holder Perturbations)
- o TCB workshop May 2017; RF Exposure Procedures (Broadband Liquid Above 3 GHz)
- <u>TCB workshop</u> May 2017; RF Exposure Procedures (LTE Band 41 Power Class 2)
- <u>TCB workshop</u> November 2017; RF Exposure Procedures (LTE UL/DL Carrier Aggregation SAR)
- <u>TCB workshop</u> April 2018; RF Exposure Procedures (LTE DL CA SAR Test Exclusion)
- <u>TCB workshop</u> October 2018; RF Exposure Procedures (LTE Inter-Band Uplink Carrier Aggregation Interim Procedures)
- <u>TCB workshop</u> April 2019; RF Exposure Procedures (802.11ax SAR Testing)
- <u>TCB workshop</u> November 2019; RF Exposure Policy Updates (5G NR FR1 NSA EN-DCUE SAR Evaluations)
- <u>TCB workshop</u> April 2021; RF Exposure Procedures (Remarks on Test Reductions via Data Referencing for Closely Related Products)

3. Facilities and Accreditation

The test sites and measurement facilities used to collect data are located at

47173 Benicia Street	47266 Benicia Street		
SAR Lab A	SAR Lab 1		
SAR Lab B	SAR Lab 2		
SAR Lab C	SAR Lab 3		
SAR Lab D	SAR Lab 4		
SAR Lab E	SAR Lab 5		
SAR Lab F	SAR Lab 6		
SAR Lab G	SAR Lab 8		
SAR Lab H	SAR Lab 9		
	SAR Lab 10		
	SAR Lab 11		
	SAR Lab 12		
	SAR Lab 13		

UL Verification Services Inc. is accredited by A2LA, Certificate Number 0751.05

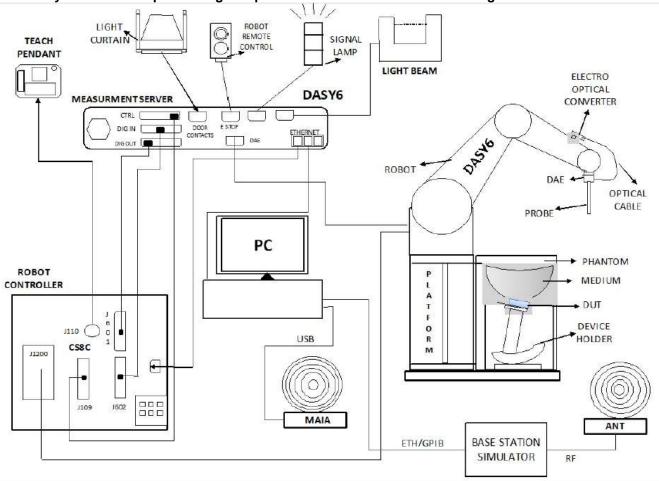
The Test Lab Conformity Assessment Body Identifier (CABID)

Location	CABID	Company Number	
47173 Benicia Street, Fremont, CA, 94538 UNITED STATES	1160404	2324A	
47266 Benicia Street, Fremont, CA, 94538 UNITED STATES	US0104	22541	

4. SAR Measurement System & Test Equipment

4.1. SAR Measurement System

The DASY system used for performing compliance tests consists of the following items:



- A standard high precision 6-axis robot with controller, teach pendant and software. An arm extension for accommodating the data acquisition electronics (DAE).
- An isotropic Field probe optimized and calibrated for the targeted measurement.
- A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, ADconversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-optical converter (EOC) performs the conversion from optical to electrical signals for the digital communication to the DAE. To use optical surface detection, a special version of the EOC is required. The EOC signal is transmitted to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- The Light Beam used is for probe alignment. This improves the (absolute) accuracy of the probe positioning.
- A computer running Win7, Win10 and the DASY52¹ and DASY6² software.
- Remote control and teach pendant as well as additional circuitry for robot safety such as warning lamps, etc.
- The phantom, the device holder and other accessories according to the targeted measurement.

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¹ DASY52 software used: DASY52.10.4 & S 14.6.14 and older generations.

 $^{^2}$ DASY6 software used: DASY6.14 & S 14.6.14 and older generations.

4.2. SAR Scan Procedures

Step 1: Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. The minimum distance of probe sensors to surface is 2.1 mm. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

Step 2: Area Scan

The Area Scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum locations even in relatively coarse grids. When an Area Scan has measured all reachable points, it computes the field maximal found in the scanned area, within a range of the global maximum. The range (in dB) is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE Standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan). If only one Zoom Scan follows the Area Scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of Zoom Scans has to be increased accordingly.

	\leq 3 GHz	> 3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	$5\pm1~\text{mm}$	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location	$30^\circ\pm1^\circ$	$20^{\circ}\pm1^{\circ}$
	\leq 2 GHz: \leq 15 mm 2 - 3 GHz: \leq 12 mm	$\begin{array}{l} 3-4 \ \mathrm{GHz} : \leq 12 \ \mathrm{mm} \\ 4-6 \ \mathrm{GHz} : \leq 10 \ \mathrm{mm} \end{array}$
Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area}	When the x or y dimension of measurement plane orientation the measurement resolution of x or y dimension of the test of measurement point on the test	on, is smaller than the above, must be \leq the corresponding levice with at least one

Area Scan Parameters extracted from KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz

Step 3: Zoom Scan

Zoom Scans are used to assess the peak spatial SAR values within a cubic averaging volume containing 1 g and 10 g of simulated tissue. The Zoom Scan measures points (refer to table below) within a cube whose base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the Zoom Scan evaluates the averaged SAR for 1 g and 10 g and displays these values next to the job's label.

			\leq 3 GHz	> 3 GHz	
Maximum zoom scan spatial resolution: Δx_{Zoom} , Δy_{Zoom}		≤ 2 GHz: ≤ 8 mm 2 - 3 GHz: ≤ 5 mm [*]	$3 - 4 \text{ GHz:} \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz:} \le 4 \text{ mm}^*$		
	uniform grid: $\Delta z_{Zoom}(n)$		$ 5 \text{ mm} \qquad 3 - 4 \text{ GHz:} \le 4 \text{ m} 4 - 5 \text{ GHz:} \le 3 \text{ m} 5 - 6 \text{ GHz:} \le 2 \text{ m} $		
Maximum zoom scan spatial resolution, normal to phantom surface	graded	$\Delta z_{Zoom}(1)$: between 1 st two points closest to phantom surface	\leq 4 mm	$3 - 4 \text{ GHz:} \le 3 \text{ mm}$ $4 - 5 \text{ GHz:} \le 2.5 \text{ mm}$ $5 - 6 \text{ GHz:} \le 2 \text{ mm}$	
	grid	∆z _{Zoom} (n>1): between subsequent points	$\leq 1.5 \cdot \Delta z_{Zoom}(n-1)$		
Minimum zoom scan volume x, y, z		$ \ge 30 \text{ mm} \qquad \begin{array}{c} 3 - 4 \text{ GHz:} \ge 28 \text{ m} \\ 4 - 5 \text{ GHz:} \ge 25 \text{ m} \\ 5 - 6 \text{ GHz:} \ge 22 \text{ m} \end{array} $			
Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE					

P1528-2011 for details.

^{*} When zoom scan is required and the <u>reported</u> SAR from the *area scan based 1-g SAR estimation* procedures of KDB 447498 is $\leq 1.4 \text{ W/kg}$, $\leq 8 \text{ mm}$, $\leq 7 \text{ mm}$ and $\leq 5 \text{ mm}$ zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

Step 4: Power drift measurement

The Power Drift Measurement measures the field at the same location as the most recent power reference measurement within the same procedure, and with the same settings. The Power Drift Measurement gives the field difference in dB from the reading conducted within the last Power Reference Measurement. This allows a user to monitor the power drift of the device under test within a batch process. The measurement procedure is the same as Step 1.

4.3. Test Equipment

The measuring equipment used to perform the tests documented in this report has been calibrated in accordance with the manufacturers' recommendations, and is traceable to recognized national standards.

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
Netw ork Analyzer	R&S	ZNLE6	171919	2/18/2023
Dielectric Probe Kit	SPEAG	DAK 3.5mm Probe	80345	11/16/2023
Shorting Block	SPEAG	DAK-3.5 Short	SM DAK 200 BA	11/16/2023
Thermometer*	Fisher Scientific	Z540	T1130	8/1/2022
Netw ork Analyzer	R&S	ZNLE6	13230012K56-101274-mn	2/15/2023
Dielectric Probe Kit	SPEAG	DAK 3.5mm Probe	1082	9/19/2022
Shorting Block	SPEAG	DAK-3.5 Short	SM DAK 200 BA	9/19/2022
Thermometer	Fisher Scientific	Z540	170064398	9/1/2022
Vector Reflectometer	Copper Mountain	DAKS VNA R140	170514	4/25/2023
Dielectric Probe Kit	Speag	DAK 3.5mm Probe	SM DAK 520 AA	3/9/2023
Shorting Block	Speag	DAK-3.5 Short	SM DAK 200 CA	3/9/2023
Thermometer	Traceable	4353	221312857	3/3/2024

Note(s):

*Equipment not used past calibration due date.

System Check

<u>oyacın oncon</u>				
Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
Synthesized Signal Generator	Agilent	N5181A	MY50140610	1/26/2023
Pow er Meter	Keysignt	N1912a	MY55196007	1/25/2023
Pow er Sensor	Agilent	N1921A	MY52270022	1/25/2023
Pow er Sensor	Agilent	N1921A	MY5220012	1/25/2023
Amplifier	Miteq	147117-1E	1795093	N/A
Directional Coupler	SMA	C8060-102	2717	N/A
DC Pow er Supply	Sorensen	XT15-4	1817A02680	N/A
Synthesized Signal Generator	Agilent	N5181A	MY50140630	1/25/2023
Pow er Meter	Agilent	N1912A	MY50001018	1/25/2023
Pow er Sensor	Agilent	N1921A	MY53260010	2/3/2023
Pow er Sensor	Agilent	N1921A	MY 5226009	1/25/2023
Amplifier	Miteq	1795092	147117-1E	N/A
Directional Coupler	SMA	C8050-102	4062	N/A
DC Pow er Supply	H/P	6296A	2841A-05955	N/A
Synthesized Signal Generator	R&S	SMB 100A	1406-6000K03-180970-zC	2/16/2023
Pow er Meter	HP	437B	3125U11364	1/25/2023
Pow er Sensor	HP	8481A	HA2022C004446	1/25/2023
Pow er Sensor	R&S	NRP50S	1419 0087K02-101250-pe	2/16/2023
Synthesized Signal Generator	R&S	SMB 100A	1406 600K03-180968-Gx	2/18/2023
Pow er Meter	HP	437B	HA2022C004449	1/25/2023
Pow er Sensor	HP	8481A	HA2022C004445	1/25/2023
Pow er Sensor	R&S	NRP18A	1424 6815K02-100992-iu	2/19/2023
Synthesized Signal Generator	Rohde & Schwarz	SMB 100A	1406.6000K03-180969-Yc	2/16/2023
Pow er Meter	Keysight	N1911A	MY55196015	1/26/1023
Pow er Sensor	Agilent	N1921A	MY53260001	1/25/2023
Pow er Sensor	Rohde & Schwarz	NRP18A	1424.6815K02-100994-RE	2/19/2023
Directional Coupler	Werlatone	C8060-102	2710	N/A
Synthesized Signal Generator	R & S	SMU 200A	102448	7/15/2023
Pow er Meter*	R & S	NRP2	102818-pb	7/25/2022
Pow er Sensor	R & S	NRP-Z81	106316-XJ	8/28/2022
Amplifier	AR	20S1G4M4	337209	N/A
Directional Coupler	Krytar	158010	142255	N/A

Note(s):

*Equipment not used past calibration due date.

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Lab Equipment

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
E-Field Probe (SAR Lab C)	SPEAG	EX3DV4	7500	3/25/2023
E-Field Probe (SAR Lab E)	SPEAG	EX3DV4	3885	9/23/2022
E-Field Probe (SAR Lab F)	SPEAG	EX3DV4	3749	11/16/2023
E-Field Probe (SAR Lab G)	SPEAG	EX3DV4	7585	4/27/2023
E-Field Probe (SAR Lab H)	SPEAG	EX3DV4	7448	2/25/2023
E-Field Probe (SAR Lab 1)	SPEAG	EX3DV4	3991	8/20/2022
E-Field Probe (SAR Lab 4)	SPEAG	EX3DV4	3929	3/23/2023
E-Field Probe (SAR Lab 12)	SPEAG	EX3DV4	3686	1/18/2023
Data Acquisition Electronics (SAR Lab C)	SPEAG	DA E4	1545	3/23/2023
Data Acquisition Electronics (SAR Lab E)	SPEAG	DA E4	1377	9/20/2022
Data Acquisition Electronics (SAR Lab F)	SPEAG	DAE4	1257	9/15/2022
Data Acquisition Electronics (SAR Lab G)	SPEAG	DA E4	1472	1/7/2023
Data Acquisition Electronics (SAR Lab 1)	SPEAG	DA E4	1359	1/7/2023
Data Acquisition Electronics (SAR Lab 4)	SPEAG	DA E4	1433	2/23/2023
Data Acquisition Electronics (SAR Lab 12)	SPEAG	DA E4	1380	8/11/2022

Lab Equipment

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
System Validation Dipole	SPEAG	D1640V2	324	3/8/2023
System Validation Dipole	SPEAG	D2450V2	706	1/13/2023
System Validation Dipole	SPEAG	D2600V2	1006	9/29/2022
System Validation Dipole	SPEAG	D3700V2	1039	5/6/2023
System Validation Dipole	SPEAG	D5GHzV2	1168	11/24/2022
System Validation Dipole	SPEAG	D5GHzV2	1003	2/23/2023

<u>OTHER</u>

Name of Equipment	Manufacturer	Type/Model	T Number	Serial No.	Cal. Due Date
Wideband Radio Communication Tester	R&S	CMW 500	85940	137877	2/18/2023
Wideband Radio Communication Tester	R&S	CMW 500	85719	135390	2/20/2023
Wideband Radio Communication Tester	R&S	CMW 500	80580	132910	2/19/2023
Wideband Radio Communication Tester	R&S	CMW 500	85698	135393	2/18/2023
Wideband Radio Communication Tester	R&S	CMW 500	81849	124594	2/18/2023
Wideband Radio Communication Tester	R&S	CMW 500	85348	125236	2/15/2023
Wideband Radio Communication Tester	R&S	CMW 500	209235	170415	2/22/2023
Wideband Radio Communication Tester	R&S	CMW 500	208643	170416	2/15/2023
Wideband Radio Communication Tester	R&S	CMW 500	85789	137873	2/16/2023
Wideband Radio Communication Tester	R&S	CMW 500	85781	135384	2/16/2023
Wideband Radio Communication Tester	R&S	CMW 500	85763	134852	2/20/2023
Wideband Radio Communication Tester	R&S	CMW 500	85727	134854	2/21/2023
Wideband Radio Communication Tester	R&S	CMW 500	86119	137875	2/17/2023
Power Meter	Keysight Technologies	N1912A	N/A	MY55196007	1/25/2023
Power Sensor	Agilent	N1921A	N/A	MY52270022	1/25/2023
Power Meter	Keysight Technologies	N1912A	N/A	MY55196004	1/26/2023
Power Sensor	Agilent	N1921A	N/A	MY53020038	3/2/2023

5. Measurement Uncertainty

Per KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz, when the highest measured 1-g SAR within a frequency band is < 1.5 W/kg and the measured 10-g SAR within a frequency band is < 3.75 W/kg. The expanded SAR measurement uncertainty must be \leq 30%, for a confidence interval of k = 2. If these conditions are met, extensive SAR measurement uncertainty analysis described in IEEE Std 1528-2013 is not required in SAR reports submitted for equipment approval.

Therefore, the measurement uncertainty is not required.

6. Dielectric Property Measurements & System Check

6.1. Dielectric Property Measurements

The temperature of the tissue-equivalent medium used during measurement must also be within 18° C to 25° C and within $\pm 2^{\circ}$ C of the temperature when the tissue parameters are characterized.

The dielectric parameters must be measured before the tissue-equivalent medium is used in a series of SAR measurements. The parameters should be re-measured after each 3 - 4 days of use; or earlier if the dielectric parameters can become out of tolerance; for example, when the parameters are marginal at the beginning of the measurement series.

Tissue dielectric parameters were measured at the low, middle and high frequency of each operating frequency range of the test device.

The dielectric constant (ϵ r) and conductivity (σ) of typical tissue-equivalent media recipes are expected to

be within \pm 5% of the required target values; but for SAR measurement systems that have implemented the SAR error compensation algorithms documented in IEEE Std 1528-2013, to automatically compensate the measured SAR results for deviations between the measured and required tissue dielectric parameters, the tolerance for ϵ r and σ may be relaxed to \pm 10%. This is limited to frequencies \leq 3 GHz.

Tissue Dielectric Parameters

FCC KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz

Torget Frequency (MHz)	He	ead	Boo	ły
Target Frequency (MHz)	ε _r	σ (S/m)	ε _r	σ (S/m)
150	52.3	0.76	61.9	0.80
300	45.3	0.87	58.2	0.92
450	43.5	0.87	56.7	0.94
835	41.5	0.90	55.2	0.97
900	41.5	0.97	55.0	1.05
915	41.5	0.98	55.0	1.06
1450	40.5	1.20	54.0	1.30
1610	40.3	1.29	53.8	1.40
1800 – 2000	40.0	1.40	53.3	1.52
2450	39.2	1.80	52.7	1.95
3000	38.5	2.40	52.0	2.73
5000	36.2	4.45	49.3	5.07
5100	36.1	4.55	49.1	5.18
5200	36.0	4.66	49.0	5.30
5300	35.9	4.76	48.9	5.42
5400	35.8	4.86	48.7	5.53
5500	35.6	4.96	48.6	5.65
5600	35.5	5.07	48.5	5.77
5700	35.4	5.17	48.3	5.88
5800	35.3	5.27	48.2	6.00

IEEE Std 1528-2013

Refer to Table 3 within the IEEE Std 1528-2013

IEC 62209-1

Refer to Table A.3 within the IEC 62209-1

Dielectric Property Measurements Results:

SAR		Band	Tissue	Frequency	Relativ	ve Permittiv	ity (ɛr)	Co	onductivity	(σ)
Lab	Date	(MHz)	Туре	(MHz)	Measured	Target	Delta (%)	Measured	Target	Delta (%)
				1640	41.03	40.25	1.93%	1.36	1.42	-4.40%
С	7/24/2022	1640	Head	1625	41.04	40.28	1.89%	1.35	1.41	-3.92%
				1665	41.07	40.22	2.13%	1.36	1.32	3.25%
				2450	37.94	39.20	-3.21%	1.87	1.80	3.89%
Е	7/17/2022	2450	Head	2400	38.01	39.30	-3.27%	1.84	1.75	4.76%
				2500	37.85	39.14	-3.29%	1.91	1.85	2.75%
				2450	41.09	39.20	4.82%	1.85	1.80	2.50%
Е	7/21/2022	2450	Head	2400	41.13	39.30	4.67%	1.81	1.75	3.16%
				2500	41.00	39.14	4.76%	1.88	1.85	1.62%
				2450	38.43	39.20	-1.96%	1.87	1.80	4.06%
Е	7/25/2022	2450	Head	2400	38.49	39.30	-2.05%	1.84	1.75	4.76%
				2500	38.35	39.14	-2.01%	1.91	1.85	3.13%
				5250	36.16	35.93	0.63%	4.69	4.70	-0.36%
F	7/25/2022	5250	Head	5150	36.37	36.05	0.90%	4.57	4.60	-0.74%
				5350	35.98	35.82	0.45%	4.81	4.80	0.14%
				5250	34.84	35.93	-3.04%	4.55	4.70	-3.21%
G	7/25/2022	5250	Head	5150	35.03	36.05	-2.82%	4.45	4.60	-3.32%
				5350	34.67	35.82	-3.21%	4.65	4.80	-3.13%
				2600	39.13	39.93	-2.00%	2.00	1.96	1.67%
1	7/25/2022	2600	Head	2495	38.35	39.14	-2.03%	1.91	1.85	3.32%
				2690	37.96	38.90	-2.41%	2.06	2.06	0.22%
				3700	39.40	37.70	4.51%	2.97	3.12	-4.66%
4	7/25/2022	3700	Head	3600	39.60	37.82	4.72%	2.88	3.01	-4.34%
				3800	39.27	37.59	4.48%	3.07	3.22	-4.71%
			1	1640	39.91	40.25	-0.85%	1.29	1.31	-1.07%
12	7/18/2022	1640	Head	1625	39.94	40.28	-0.84%	1.28	1.30	-1.11%
				1665	39.86	40.22	-0.88%	1.31	1.32	-1.06%

6.2. System Check

SAR system verification is required to confirm measurement accuracy, according to the tissue dielectric media, probe calibration points and other system operating parameters required for measuring the SAR of a test device. The system verification must be performed for each frequency band and within the valid range of each probe calibration point required for testing the device. The same SAR probe(s) and tissue-equivalent media combinations used with each specific SAR system for system verification must be used for device testing. When multiple probe calibration points are required to cover substantially large transmission bands, independent system verifications are required for each probe calibration point. A system verification must be performed before each series of SAR measurements using the same probe calibration point and tissue-equivalent medium. Additional system verification should be considered according to the conditions of the tissue-equivalent medium and measured tissue dielectric parameters, typically every three to four days when the liquid parameters are re-measured or sooner when marginal liquid parameters are used at the beginning of a series of measurements.

System Performance Check Measurement Conditions:

- The measurements were performed in the flat section of the TWIN SAM or ELI phantom, shell thickness: 2.0 ±0.2 mm (bottom plate) filled with Body or Head simulating liquid of the following parameters.
- The depth of tissue-equivalent liquid in a phantom must be ≥ 15.0 cm for SAR measurements ≤ 3 GHz and ≥ 10.0 cm for measurements > 3 GHz.
- The DASY system with an E-Field Probe was used for the measurements.
- The dipole was mounted on the small tripod so that the dipole feed point was positioned below the center marking of the flat phantom section and the dipole was oriented parallel to the body axis (the long side of the phantom). The standard measuring distance was 10 mm (above 1 GHz) and 15 mm (below 1 GHz) from dipole center to the simulating liquid surface.
- The coarse grid with a grid spacing of 15 mm was aligned with the dipole. For 5 GHz band - The coarse grid with a grid spacing of 10 mm was aligned with the dipole.
- Special 7x7x7 (below 3 GHz) and/or 8x8x7 (above 3 GHz) fine cube was chosen for the cube.
- Distance between probe sensors and phantom surface was set to 3 mm.
- For 5 GHz band Distance between probe sensors and phantom surface was set to 2.5 mm
- The dipole input power (forward power) was 100 mW.
- The results are normalized to 1 W input power.

System Check Results

The 1-g and 10-g SAR measured with a reference dipole, using the required tissue-equivalent medium at the test frequency, must be within $\pm 10\%$ of the manufacturer calibrated dipole SAR target. Refer to Appendix B for the SAR System Check Plots.

				Dipole	Me	easured Res	ults for 1g S	AR	Me	SAR	Plot No. 1 2 3 4 5 6		
SAR Lab	Date	Tissue Type	Dipole Type _Serial #	Cal. Due Data	Zoom Scan to 100 mW	Normalize to 1 W	Target (Ref. Value)	Delta ±10 %	Zoom Scan to 100 mW	Normalize to 1 W	Target (Ref. Value)	Delta ±10 %	
С	7/24/2022	Head	D1640V2 SN:324	3/8/2023	3.710	37.10	34.08	8.86%	2.010	20.10	18.67	7.66%	1
Е	7/17/2022	Head	D2450V2 SN:706	1/13/2023	5.660	56.60	53.80	5.20%	2.620	26.20	25.00	4.80%	
Е	7/21/2022	Head	D2450V2 SN:706	1/13/2023	5.720	57.20	53.80	6.32%	2.640	26.40	25.00	5.60%	
Е	7/25/2022	Head	D2450V2 SN:706	1/13/2023	5.740	57.40	53.80	6.69%	2.650	26.50	25.00	6.00%	2
F	7/25/2022	Head	D5GHzV2 SN:1168 (5.25 GHz)	11/24/2022	7.430	74.30	73.60	0.95%	2.150	21.50	21.20	1.42%	3
G	7/25/2022	Head	D5GHzV2 SN:1003 (5.25 GHz)	2/23/2023	7.390	73.90	81.70	-9.55%	2.170	21.70	23.30	-6.87%	4
1	7/25/2022	Head	D2600V2 SN:1006	9/29/2023	5.740	57.40	54.94	4.48%	2.550	25.50	25.24	1.03%	5
4	7/25/2022	Head	D3700V2 SN:1039	5/6/2023	6.540	65.40	69.27	-5.59%	2.460	24.60	25.68	-4.21%	6
12	7/18/2022	Head	D1640V2 SN:324	3/18/2023	3.550	35.50	34.08	4.17%	1.940	19.40	18.67	3.91%	7

7. Test Rationale

7.1. Purpose

This application for certification is leveraging the data reuse procedure from TCB workshop April 2021; RF Exposure Procedures (Remarks on Test Reductions via Data Referencing for Closely Related Products) based on reference FCC ID: BCG-E8139A to cover variant FCC ID: BCG-E8146A, BCG-E8147A, BCG-E8148A. The major difference between the parent/reference model and the variant model is the depopulation in the variant model of the mmWave transmitter. All other circuitry and features are identical. The data reuse test plan was approved via manufacturer KDB inquiry.

7.2. Data Reuse Approach

Full RF exposure testing was performed on the parent model. The configurations with the highest SAR values for each equipment class were identified. These configurations were tested on the variant models.

The variation in SAR values was well within the uncertainty budget of the SAR test equipment. The variant SAR results and worst case parent SAR values are summarized in section 1.

8. Measured and Reported (Scaled) SAR Results

8.1. A2885 Spot Check Results

Equipment	Wireless		RF Exposure		Power	Dist.	Test			Freq.	RB		RB	Pow	er (dBm)	1-g S/	AR (W/kg)	10-g S	AR (W/kg)	Plot
Class	Technologies	Antenna	Conditions	Mode	Mode	(mm)	Positio	on C	Ch #.	(MHz)	Allocatio	'n	offset	Tune-up Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
TNE	MSS	ANT 4	Hotspot	1-PRB SC- FDMA	Mode B	5	Edge	2 26	62466	1625.1	N/A		N/A	21.10	20.10	0.815	1.026	0.382	0.481	1
PCE	n41	ANT 2	Head	pi/2 BPSK	Mode A	0	Left T	īlt 51	8598	2593.0	135		67	16.60	16.50	0.756	0.774	0.276	0.282	2
CBE	LTE Band 48	ANT 4	Head	QPSK	Mode A	0	Left To	uch 56	6640	3690.0	50		24	21.00	20.00	0.689	0.867	0.238	0.300	3
														Bou	er (dBm)	1	R (W/kg)	10-g SAF		
Equipment	Wireless Technologies	Antenna	RF Exposur	e Mode	Powe Mode			est sition	Ch#.	Freq. (MHz)	Area S Max. S	AR I	Duty Cycle		T Ó	-				Plot No.
01233	recimologies		Conditions		Woode	. (111	1) 10	310011		(11112)	(W/kę	J)		Limit	Meas.	Meas.	Scaled	Meas.	Scaled	140.
DTS	Wi-Fi 2.4GHz Cell OF	F ANT 3	Hotspot	802.11b	Mode	в 5	Ed	ge 4	6	2437.0	0.93		100%	21.00	19.99	0.778	0.982	0.346	0.437	4
U-NII	Wi-Fi 5.3 GHz	ANT 5	Body	802.11n (HT40)	Mode	в 5	R	ear	54	5270.0	1.50	D	96.12%	17.50	16.27	0.717	0.990	0.197	0.272	5
Equipment	Wireless		RF Expos	ure	Po	wer	Dist.	Test			Freq.			Power (dBm)	1-g SAR	(W/kg)	10-g SA	R (W/kg)	Plot
Class	Technologies	Antenn	Conditio		Mo	ode	(mm)	Position	Ch#		MHz)	Duty C	ycie 1	Fune-up Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
DSS	Bluetooth (Pstandalon	e) ANT 4	Hotspo	GFSł	K Mod	de B	5	Edge 2	39	2	441.0	100)%	20.00	19.49	0.638	0.717	0.257	0.289	6

8.2. A2886 Spot Check Results

Equipment	Wireless		RF Exposure		Pow er	Dist.	Test			Frea.	RB	RB		Pow e	r(dBm)	1-g SAR (W/kg)		10-g SAR (W/kg)		Plot
Class	Technologies	Antenna	Conditions	Mode	Mode	(mm)	Positic	Ch	#.	(MHz)	Allocation		t	Tune-up Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
TNE	MSS	ANT 4	Hotspot	1-PRB SC- FDMA	Mode B	5	Edge	2 2624	66	1625.1	N/A	N/A		21.10	20.10	0.804	1.012	0.397	0.500	7
PCE	n41	ANT 2	Head	pi/2 BPSK	Mode A	0	Left T	ilt 5185	98 :	2593.0	135	67		16.60	16.50	0.745	0.762	0.276	0.282	8
CBE	LTE Band 48	ANT 4	Head	QPSK	Mode A	0	Left Tou	ich 5664	40 :	3690.0	50	24		21.00	20.00	0.555	0.699	0.192	0.242	9
														_						
Equipment	Wireless		RF Exposure	Mode	Powe	r Dis	t. Te	st	h#.	Freq.	Area Sc Max, SA				er (dBm)	1-g S	AR (W/kg)	10-g S/	AR (W/kg)	Plot
Class	Technologies	Antenna	Conditions	Mode	Mode	(mn	i) Posi	tion	n#.	(MHz)	(W/kg		ycie	Tune-up Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
DTS	Wi-Fi 2.4GHz Cell OFF	ANT 3	Hotspot	802.11b	Mode I	в 5	Edg	e 4	6	2437.0	1.630	100	%	21.00	19.99	0.748	0.944	0.285	0.360	10
NII	Wi-Fi 5.3 GHz Cell OFF	ANT 5	Body	802.11n (HT40)	Mode I	в 5	Re	ar t	54	5270.0	1.950	96.12	2%	17.50	16.27	0.795	1.098	0.227	0.313	11
		•		·	•										·		·	·	•	
Equipment	Wireless		RF Expos			ower	Dist.	Test			Freq.			Power (d	Bm)	1-g SAR	: (W/kg)	10-g SA	R (W/kg)	Plot
Class	Technologies	Antenn	Conditio			Node	(mm)	Position	Ch#		(MHz)	Duty Cycle		une-up Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
DSS	Bluetooth (Pstandalone	e) ANT 4	Hotspo	t GFS	K M	ode B	5	Edge 2	39	2	441.0	100%	2	20.00	19.49	0.745	0.838	0.295	0.332	12

8.3. A2887, A2888 Spot Check Results

Equipment	Wireless		RF Exposure		Powe	r Dist	Τe	est		Freq.	R	Ð	RB	Pov	er (dBm)	1-g S/	AR (W/kg)	10-g S/	AR (W/kg)	Plot
Class	Technoligies	Antenna	Conditions	Mode	Mode			ition	Ch #.	(MHz)		_	offset	Tune-u Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
PCE	n41	ANT 2	Head	pi/2 BPSK	Mode	A 0	Lef	t Tilt 5	518598	2593.0	D 13	35	67	16.60	16.50	0.830	0.849	0.304	0.311	13
CBE	LTE Band 48	ANT 4	Head	QPSK	Mode	A 0	Left 7	Fouch	56640	3690.0	0 50	0	24	21.00	20.00	0.684	0.861	0.236	0.297	14
											Area S	Con		Bow	er (dBm)	1-0.54	R (W/kg)	10-g SA	P (\\\/ka)	
Equipment	Wireless	Antenna	RF Exposure	Mode	Pow er	Dist.	Tes		Ch #.	Freq.			Duty Cycle				,		,	Plot
Class	Technologies		Conditions		Mode	(mm)	Posit	ion		(MHz)	(W/k	g)		Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
DTS	Wi-Fi 2.4GHz Cell OFF	ANT 3	Hotspot	802.11b	Mode B	5	Edge	e 4	6	2437.0	0.99	0	100%	21.00	19.99	0.902	1.138	0.395	0.498	15
U-NII	Wi-Fi 5.3 GHz Cell OFF	ANT 5	Body	802.11n (HT40)	Mode B	5	Rea	ar	54	5270.0	2.19	0	96.12%	17.50	16.27	0.742	1.025	0.209	0.289	16
Equipment	Wireless		RF Exposu	ure	. F	Power	Dist.	Test			Freq.			Pow er	dBm)	1-g SAR	(W/kg)	10-g SA	R (W/kg)	Plot
Class	Technologies	Antenna	Condition	Mod	de l	Mode	(mm)	Position	C	h #.	(MHz)	Duty	y Cycle	Tune-up Limit	Meas.	Meas.	Scaled	Meas.	Scaled	No.
DSS	Bluetooth (Pstandalone)	ANT 4	Hotspot	GFS	SK N	lode B	5	Edge 2	3	39	2441.0	1	00%	20.00	19.49	0.654	0.735	0.237	0.267	17

Appendixes

Refer to separated files for the following appendixes.

- Appendix A: SAR Setup Photos
- Appendix B: SAR System Check Plots
- **Appendix C: SAR Highest Test Plots**
- Appendix D: SAR Tissue Ingredients
- Appendix E: SAR Probe Certificates
- Appendix F: SAR Dipole Certificates

END OF REPORT